Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/660,950	O'DONNELL, SHAWN
Examiner	Art Unit
Maikhanh Nguyen	2176

	SEARCHED					
Class	Subclass	Date	Examiner			
715	505	10/22/2005	МК			
715	506,507	10/22/2005	МК			
707	10	10/22/2005	MK			
Updated	Search	5/16/2006	MK			
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		-			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Name Search	10/22/2005	MK		
West Search	10/22/2005	MK		
NPL (IEEE)	10/22/2005	MK		
West Updated (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB)	5/16/2006	MK		